

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Kristian Blidegn
Filed : July 10, 2003

Art Unit : Unknown
Examiner : Unknown

Title : ACCURATE POSITIONING OF COMPONENTS OF AN OPTICAL
ASSEMBLY

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450


INFORMATION DISCLOSURE STATEMENT

Copies of the references listed on the attached form PTO-1449 are enclosed.

This statement is being filed with the application. Please apply any charges or credits to
Deposit Account No. 06-1050.

Respectfully submitted,

Date: July 10, 2003



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Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 14069-004001	Application No.
	Applicant Kristian Blidegn		
	Filing Date July 10, 2003	Group Art Unit	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	US2002/0006151A1	01/17/2002	Yamauchi			
	AB	4,449,825	05/22/1984	May			
	AC	4,912,530	03/27/1990	Bessho			
	AD	5,333,369	08/02/1994	Miyairi et al.			
	AE	5,781,297	07/14/1998	Castore			
	AF	6,091,481	07/18/2000	Mori			
	AG	6,018,391	01/25/2000	Yoshida			
	AH	6,313,460 B1	11/06/2001	Haas et al.			
	AI	6,314,543 B1	11/06/2001	Yamaguchi			
	AJ	6,320,242 B1	11/20/2001	Takasu et al.			
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	Heilmann et al., "Heterodyne Encoder Schemes for Sub-Nanometer Positioning," www.aspe.net/meetings/2001annual , 3 pages.
	AR	"Sparkolor Corporation Announces Passively Aligned Hybrid Flip-Chip Bonding Capability With 0.2 Micrometers . . .," Photonics Online News for photonics professionals, 2 pages, May 2, 2002
	AS	Kevin McCarthy, "Accuracy in Positioning Systems," Reprinted from The Motion Control Technology Conference Proceedings, March 19-21, 1991, 15 pages, 2/1996.
	AT	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	